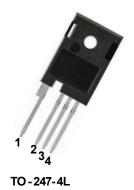
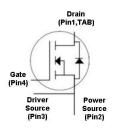


#### **Main Product Characteristics:**

| V <sub>DS</sub>     | 1200V |
|---------------------|-------|
| I <sub>D</sub>      | 76A   |
| R <sub>DS(on)</sub> | 40mΩ  |





Schematic Diagram

#### **Features and Benefits:**

- High blocking voltage with low on-resistance
- High speed switching, very low switching losses
- High blocking voltage with low on-resistance
- Fast intrinsic diode with low reverse recovery (Qrr)
- Temperature independent turn-off switching losses

# RoH5 Compliant

#### **Applications:**

- On-board charger/PFC
- EV battery chargers
- Booster/DC-DC converter
- Switch mode power supplies

# **Absolute Max Rating:**

| Symbol                          | Parameter  | Value   | Units |  |
|---------------------------------|--|---------|-------|--|
| V <sub>DS</sub>                 | Drain Source Voltage   |         | V     |  |
| V <sub>GS,max</sub>             | Gate Source Voltage, Absolute Maximum Values                                   | -8 /+22 | V     |  |
| V <sub>GS,op</sub>              | Gate Source Voltage,Recommended Operational Values                             | -4 /+15 | V     |  |
|                                 | Continuous Drain Current @Tc = 25 °C   | 76      |       |  |
| l <sub>D</sub>                  | Continuous Drain Current @T <sub>C</sub> = 100 °C                              | 53      | A     |  |
| I <sub>D(puls)</sub>            | Pulsed Drain Current, Pulse Width t <sub>P</sub> limited by T <sub>j,max</sub> |         |       |  |
| P <sub>D</sub>                  | Power Dissipation @T <sub>C</sub> = 25°C, T <sub>J</sub> = 175°C               |         | W     |  |
| T <sub>J</sub> T <sub>STG</sub> | T <sub>STG</sub> Operating Junction and Storage Temperature Range              |         | °C    |  |
| T∟                              | Soldering Temperature  | 260     | °C    |  |

**Version: Preliminary** 



## **Thermal Resistance**

| Symbol           | Characterizes                          | Тур. | Max. | Units |
|------------------|--|------|------|-------|
| R <sub>θJC</sub> | Thermal Resistance,Junction-to-case    | _    | 0.42 | °C/W  |
| R <sub>θJA</sub> | Thermal Resistance,Junction-to-ambient | _    | 33   | °C/W  |

## **Electrical Characteristics** @T<sub>A</sub>=25°C unless otherwise specified

| Symbol               | Parameter                            | Min. | Тур. | Max. | Units | Conditions  |  |
|----------------------|--------------------------------------|------|------|------|-------|---|--|
| V <sub>(BR)DSS</sub> | Drain-to-Source Breakdown Voltage    | 1200 | _    | _    | V     | V <sub>GS</sub> = 0V, I <sub>D</sub> = 100μA                                  |  |
|                      |                                      | _    | 40   | 50   | mΩ    | V <sub>GS</sub> =15V,I <sub>D</sub> = 33.3A                                   |  |
| Б                    |                                      | _    | 62   | _    |       | V <sub>GS</sub> =15V,I <sub>D</sub> =33.3A,T <sub>J</sub> =175°C              |  |
| R <sub>DS(on)</sub>  | Static Drain-to-Source On-resistance | _    | 32   | 40   |       | V <sub>GS</sub> =18V,I <sub>D</sub> = 33.3A                                   |  |
|                      |                                      | _    | 59   | _    |       | V <sub>GS</sub> =18V,I <sub>D</sub> =33.3A,T <sub>J</sub> =175°C              |  |
| $V_{GS(th)}$         | Gate Threshold Voltage               | 2.3  | _    | 3.6  | V     | $V_{DS} = V_{GS}$ , $I_D = 10$ mA   |  |
| I <sub>DSS</sub>     | Drain-to-Source Leakage Current      | _    | _    | 10   | μA    | V <sub>DS</sub> = 1200V,V <sub>GS</sub> = 0V                                  |  |
| I <sub>GSS</sub>     | Gate-to-Source Forward Leakage       | _    | _    | 100  | nA    | V <sub>GS</sub> =15V,V <sub>DS</sub> = 0V                                     |  |
| gfs                  | Transconductance                     | _    | 17   | _    | S     | V <sub>DS</sub> = 20V, I <sub>D</sub> =33.3A                                  |  |
| R <sub>g</sub>       | Internal Gate Resistance             | _    | 0.9  | _    | Ω     | V <sub>AC</sub> = 25mV, f =1MHz   |  |
| Qg                   | Total Gate Charge                    | _    | 75   | _    |       | V <sub>DS</sub> = 800V,   |  |
| Q <sub>gs</sub>      | Gate-to-Source Charge                | _    | 15   | _    | nC    | $V_{GS} = -4/+15V$ ,  |  |
| $Q_{gd}$             | Gate-to-Drain("Miller") Charge       | _    | 35   | _    |       | I <sub>D</sub> = 33.3A  |  |
| t <sub>d(on)</sub>   | Turn-on Delay Time                   | _    | 30   | _    |       |   |  |
| tr                   | Rise Time                            | _    | 18   | _    | no    | $V_{DS} = 800V, V_{GS} = -4/+15V$ $I_{D} = 33.3A, Rg = 2.5\Omega$ $L = 120uH$ |  |
| t <sub>d(off)</sub>  | Turn-Off Delay Time                  | _    | 32   | _    | ns    |   |  |
| t <sub>f</sub>       | Fall Time                            | _    | 10   | _    |       |   |  |
| Eon                  | Turn on Switching Energy             | _    | 260  | _    | 1     | L - 120un   |  |
| E <sub>off</sub>     | Turn off Switching Energy            | _    | 50   | _    | μJ    |   |  |
| Ciss                 | Input Capacitance                    | _    | 2160 | _    |       | \/ - 0\/  |  |
| Coss                 | Output Capacitance                   | _    | 130  | _    | pF    | $V_{GS} = 0V$   |  |
| C <sub>rss</sub>     | Reverse Transfer Capacitance         | _    | 10   | _    |       | V <sub>DS</sub> = 1000V   |  |
| E <sub>oss</sub>     | Coss Stored Energy                   | _    | 80   | _    | μJ    | f =100KHz   |  |

# Electrical Characteristics of the Diode@T<sub>A</sub>=25°C unless otherwise specified

| Symbol           | Parameter                        | Min. | Тур. | Max. | Units | Conditions   |
|------------------|----------------------------------|------|------|------|-------|--|
| Is               | Continuous diode forward current | _    | 76   | _    | Α     | V <sub>GS</sub> = -4V, Tc = 25°C                     |
| V <sub>SD</sub>  | Diode Forward Voltage            | _    | 3.8  | _    | V     | V <sub>GS</sub> = -4V, I <sub>SD</sub> = 20A         |
| trr              | Reverse recovery time            | _    | 56   | _    | ns    | \/ - 000\/ \/ - 4\/                                  |
| Qrr              | Reverse Recovery Charge          | _    | 660  | _    | nC    | $V_R = 800V, V_{GS} = -4V$<br>$I_D = 33.3A, di/dt =$ |
|                  | Diode Peak Reverse Recovery      |      | 22   |      | ^     | 2325A/µS ,T <sub>J</sub> = 175°C                     |
| I <sub>RRM</sub> | Current                          | _    | 22   | _    | A     | 2323A/μ3 ,1] = 1/3 C                                 |





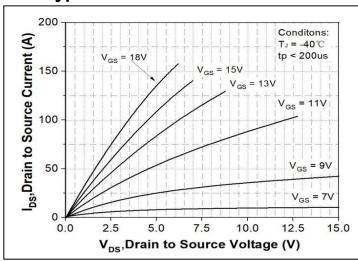


Figure 1. Typical Output Characteristics@T<sub>J</sub>=-40 °C

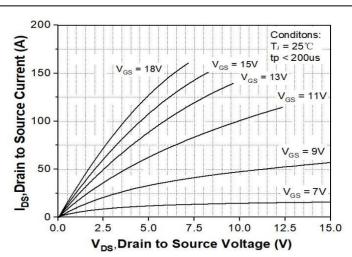


Figure2. Typical Output Characteristics@T<sub>J</sub>=25℃

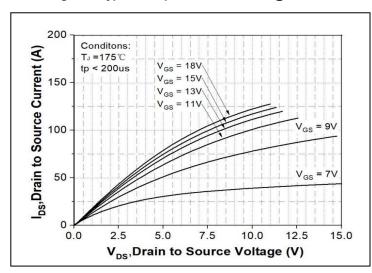


Figure3.Typical Output Characteristics@T<sub>J</sub>=175℃

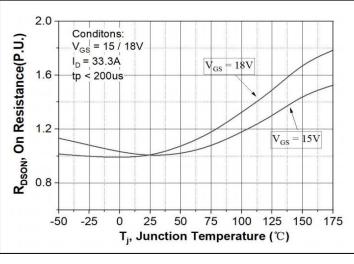


Figure 4. Normalized on-resistance vs. Temperature

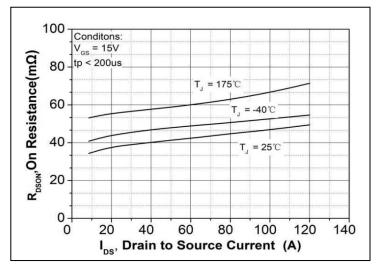


Figure 5. On-resistance vs. Drain Current

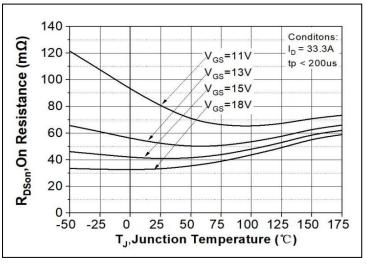
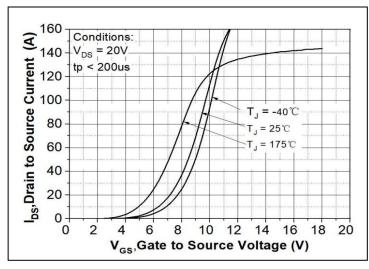


Figure 6. On-resistance vs. Temperature





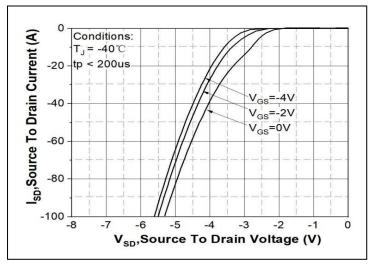
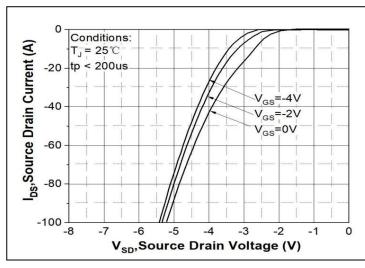


Figure 7. Transfer Characteristic for Various Junction Temperatures

Figure 8. Body Diode Characteristic @T<sub>J</sub> = -40 °C



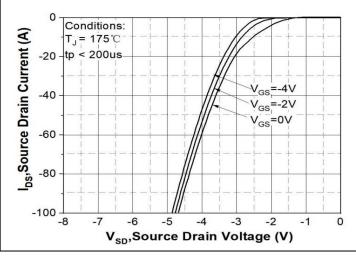
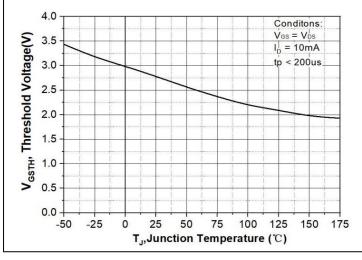


Figure 9. Body Diode Characteristic @T<sub>J</sub> = 25 °C

Figure 10. Body Diode Characteristic @T<sub>J</sub> = 175 °C



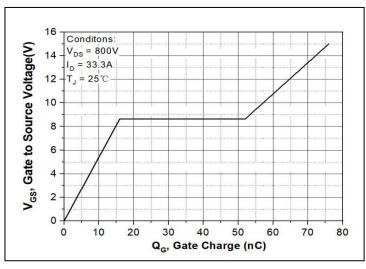
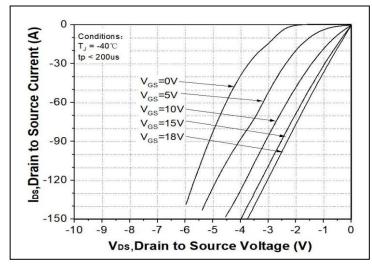


Figure 11. Threshold Voltage vs. Temperature

Figure 12. Gate Charge Characteristic





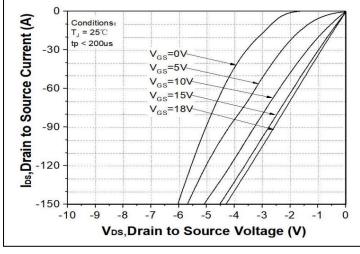
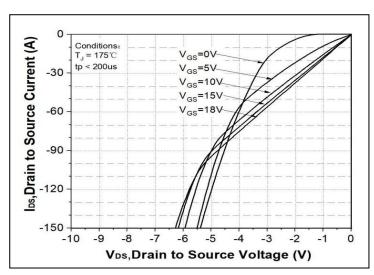


Figure 13.3rd Quadrant Characteristic @ T<sub>J</sub> = -40 °C

Figure14.3rd Quadrant Characteristic @ T<sub>J</sub> = 25 °C



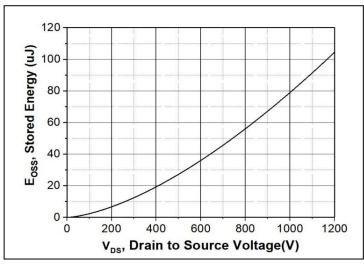
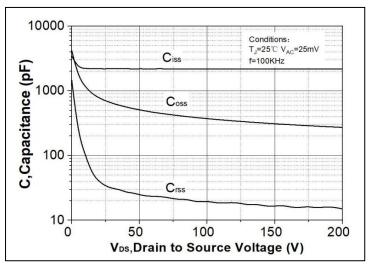


Figure15.3rd Quadrant Characteristic @ T<sub>J</sub> = 175 °C

Figure 16. Output Capacitor Stored Energy



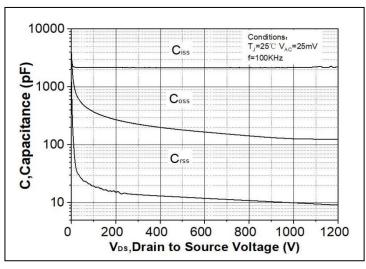


Figure 17. Capacitances vs. Drain-source Voltage (0~200V)

Figure 18. Capacitances vs. Drain-source Voltage (0~1200V)





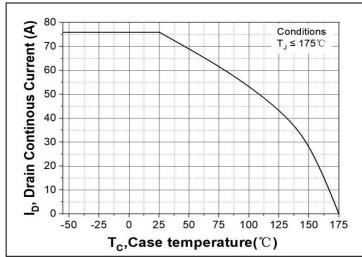


Figure 19. Continuous Drain Current Derating vs. Case Temperature

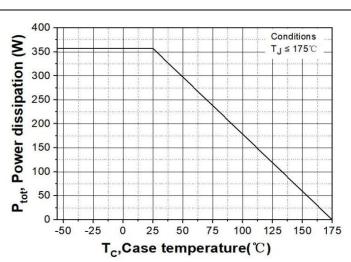


Figure 20. Maximum Power Dissipation Derating vs. Case **Temperature** 

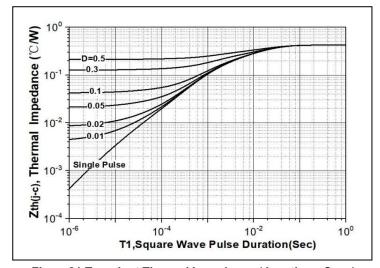


Figure21.Transient Thermal Impedance (Junction - Case)

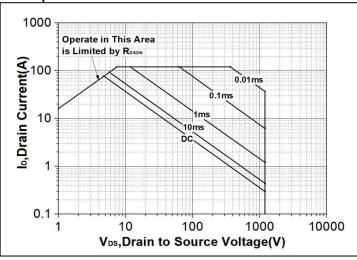
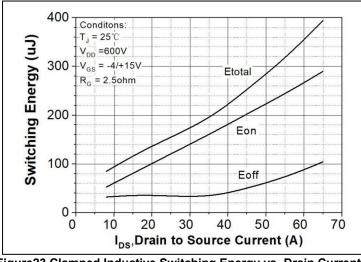


Figure 22. Safe Operating Area



 $(V_{DD} = 600V)$ 

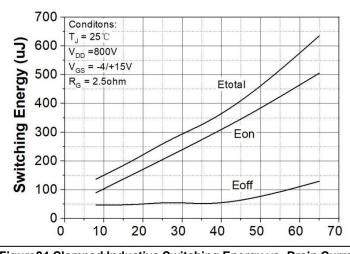
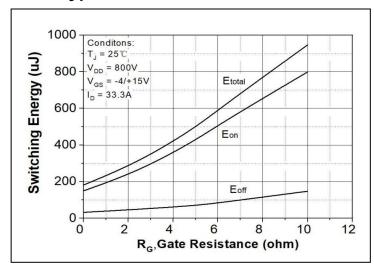


Figure 23. Clamped Inductive Switching Energy vs. Drain Current Figure 24. Clamped Inductive Switching Energy vs. Drain Current  $(V_{DD} = 800V))$ 







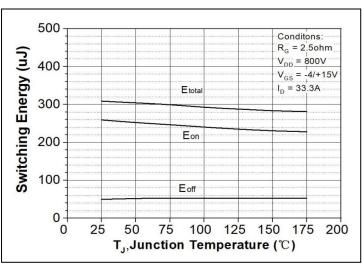


Figure25.Clamped Inductive Switching Energy vs. R<sub>G</sub>(ext)

Figure 26. Clamped Inductive Switching Energy vs. Temperature

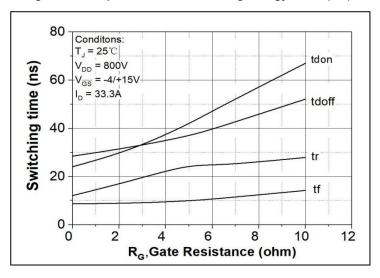


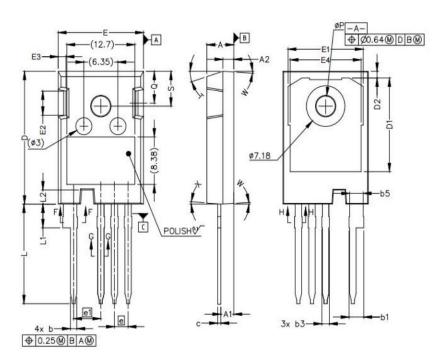
Figure27.Switching Times vs. R<sub>G</sub>(ext)

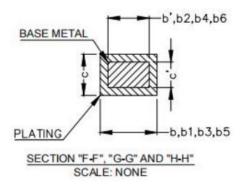




## **Mechanical Data:**

#### Unit:mm





| CVARDOL | MILLIMETERS |       |  |  |  |
|---------|-------------|-------|--|--|--|
| SYMBOL  | MIN         | MAX   |  |  |  |
| Α       | 4.83        | 5.21  |  |  |  |
| A1      | 2.29        | 2.54  |  |  |  |
| A2      | 1.91        | 2.16  |  |  |  |
| b'      | 1.07        | 1.28  |  |  |  |
| b       | 1.07        | 1.33  |  |  |  |
| b1      | 2.39        | 2.94  |  |  |  |
| b2      | 2.39        | 2.84  |  |  |  |
| b3      | 1.07        | 1.60  |  |  |  |
| b4      | 1.07        | 1.50  |  |  |  |
| b5      | 2.39        | 2.69  |  |  |  |
| b6      | 2.39        | 2.64  |  |  |  |
| c'      | 0.55        | 0.65  |  |  |  |
| С       | 0.55        | 0.68  |  |  |  |
| D       | 23.30       | 23.60 |  |  |  |
| D1      | 16.25       | 17.65 |  |  |  |
| D2      | 0.95        | 1.25  |  |  |  |
| E       | 15.75       | 16.13 |  |  |  |
| E1      | 13.10       | 14.15 |  |  |  |
| E2      | 3.68        | 5.10  |  |  |  |
| E3      | 1.00        | 1.90  |  |  |  |
| E4      | 12.38       | 13.43 |  |  |  |
| e       |             | BSC   |  |  |  |
| e1      | 5.08 BSC    |       |  |  |  |
| N       | 4           |       |  |  |  |
| L       | 17.31       | 17.82 |  |  |  |
| L1      | 3.97        | 4.37  |  |  |  |
| L2      | 2.35        | 2.65  |  |  |  |
| øР      | 3.51        | 3.65  |  |  |  |
| Q       | 5.49        | 6.00  |  |  |  |
| S       | 6.04        | 6.30  |  |  |  |
| T       | 17.5° I     |       |  |  |  |
| w       | 3.5 ° REF.  |       |  |  |  |
| X       |             | REF.  |  |  |  |





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**Version:Preliminary**